Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/812,892	BONAQUIST ET AL.
Examiner	Art Unit
TUYEN T. NGUYEN	2832

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	SEARCHED				
Class	Subclass	Date	Examiner		
336	55-62	2/18/2006	TTN		
62	52.1, 62	2/18/2006	TTN		
165	128-130	2/18/2006	TTN		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMF		
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